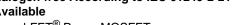


# N-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	60				
$R_{DS(on)}$ ( $\Omega$ ) at $V_{GS} = 10 \text{ V}$	0.024				
$R_{DS(on)}$ ( $\Omega$ ) at $V_{GS} = 4.5 \text{ V}$	0.028				
Q <sub>g</sub> typ. (nC)	5.2				
I <sub>D</sub> (A)	15 <sup>a, g</sup>				
Configuration	Single				

#### **FEATURES**

Halogen-free According to IEC 61249-2-21 Available



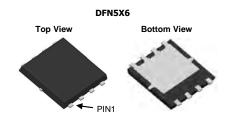


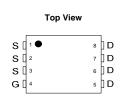
- 100 % R<sub>g</sub> Tested
- 100 % UIS Tested

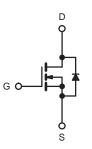
### **APPLICATIONS**

- Battery Switch
- DC/DC Converter









N-Channel MOSFET

PARAMETER Drain-source voltage		SYMBOL	LIMIT	UNIT	
		$V_{DS}$	60	V	
Gate-source voltage		V <sub>GS</sub>	± 20	V	
-	T <sub>C</sub> = 25 °C		15 <sup>a</sup>		
Continuous dusin surrent (T. 150 °C)	T <sub>C</sub> = 70 °C	1 , [	9ª		
Continuous drain current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	- I <sub>D</sub> -	10.3 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C	1	8.1 <sup>b, c</sup>		
Pulsed drain current (t = 100 μs)		I <sub>DM</sub>	40	A	
Continuous source-drain diode current	T <sub>C</sub> = 25 °C		12 <sup>a</sup>		
	T <sub>A</sub> = 25 °C	l <sub>S</sub>	3 b, c		
Single pulse avalanche current	1 0.1 ml l	I <sub>AS</sub>	15		
Single pulse avalanche energy  L = 0.1 m		E <sub>AS</sub>	11.3	mJ	
Maximum power dissipation	T <sub>C</sub> = 25 °C		35.7		
	T <sub>C</sub> = 70 °C	1 5	22.9	101	
	T <sub>A</sub> = 25 °C	P <sub>D</sub>	3.6 <sup>b, c</sup>	W	
	T <sub>A</sub> = 70 °C	1	2.3 b, c		
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Soldering recommendations (peak temperature) c			260		

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum junction-to-ambient <sup>b</sup>	t ≤ 10 s	R <sub>thJA</sub>	25	35	°C/W		
Maximum junction-to-case (drain)	Steady state	$R_{thJC}$	2.7	3.5			

- Notes
  a. Package limited
- b. Surface mounted on 1" x 1" FR4 board
- c. t = 10 s



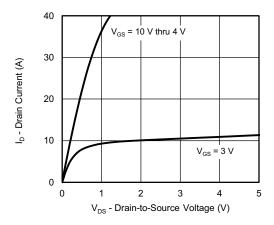
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static			•	•		L.
Drain-source breakdown voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60	-	-	V
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	J 050 A	-	33	-	\//0/
V <sub>GS(th)</sub> temperature coefficient	$\Delta V_{GS(th)}/T_J$	$I_{D} = 250 \mu\text{A}$	-	-4.8	-	mV/°C
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1	-	2.8	V
Gate-source leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	100	nA
		V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V	-	-	1	μА
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 70 °C	-	-	10	
On-state drain current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	10	-	-	Α
5		V <sub>GS</sub> =10 V, I <sub>D</sub> = 10 A	-	0.024	-	Ω
Drain-source on-state resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$	-	0.028	-	
Forward transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 10 A	-	39	-	S
Dynamic <sup>b</sup>						
Input capacitance	C <sub>iss</sub>		-	790	-	
Output capacitance	C <sub>oss</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	330	-	pF
Reverse transfer capacitance	C <sub>rss</sub>		-	14	-	
Total gate charge	Q <sub>g</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$	-	11.1	17	nC
			-	5.2	8	
Gate-source charge	Q <sub>gs</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$	-	2.2	-	
Gate-drain charge	Q <sub>gd</sub>		-	1.1	-	
Gate resistance	Rg	f = 1 MHz	0.1	0.6	1.2	Ω
Turn-on delay time	t <sub>d(on)</sub>		-	7	15	
Rise time	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, R_L = 6 \Omega, I_D \cong 5 \text{ A},$	-	21	40	1
Turn-off delay time	t <sub>d(off)</sub>	$V_{GEN} = 10^{\circ} V$ , $R_g = 1^{\circ} \Omega$	-	10	20	
Fall time	t <sub>f</sub>		-	10	20	
Turn-on delay time	t <sub>d(on)</sub>		-	13	25	ns
Rise time	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, R_L = 6 \Omega, I_D \cong 5 \text{ A},$	-	25	50	
Turn-off delay time	t <sub>d(off)</sub>	$V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	-	10	20	
Fall time	t <sub>f</sub>		-	22	45	
Drain-Source Body Diode Characterist	ics					
Continuous source-drain diode current	I <sub>S</sub>	= T <sub>C</sub> = 25 °C	-	15	-	
Pulse diode forward current	I <sub>SM</sub>		-	-	40	A
Body diode voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A, V <sub>GS</sub> = 0 V	-	0.79	1.2	V
Body diode reverse recovery time	t <sub>rr</sub>		-	30	60	ns
Body diode reverse recovery charge	Q <sub>rr</sub>	L FA 4:/4: 400 A/ - T 0500	-	60	120	nC
Reverse recovery fall time	ta	$I_F = 5 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 °\text{C}$	-	15	-	
Reverse recovery rise time	t <sub>b</sub>		-	15	-	ns

#### Notes

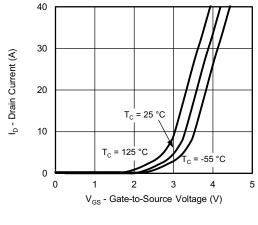
a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 % b. Guaranteed by design, not subject to production testing



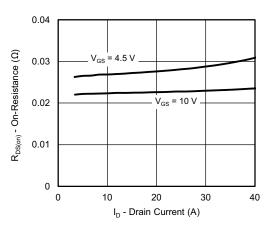
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



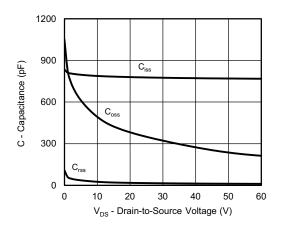
#### **Output Characteristics**



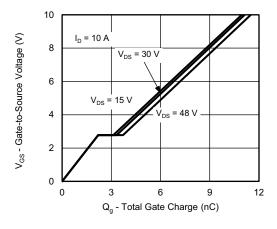
**Transfer Characteristics** 



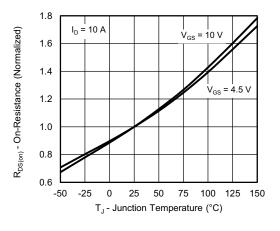
On-Resistance vs. Drain Current and Gate Voltage



Capacitance



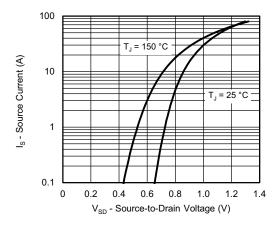
**Gate Charge** 



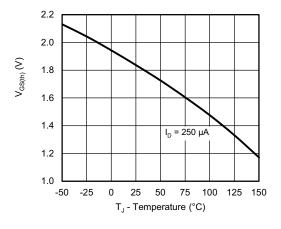
On-Resistance vs. Junction Temperature



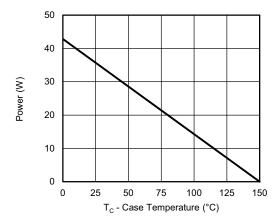
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



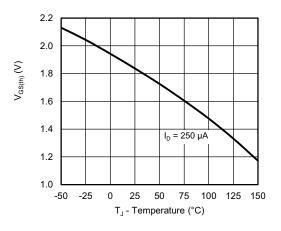
#### Source-Drain Diode Forward Voltage



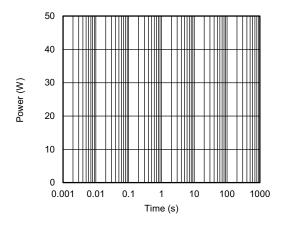
**Threshold Voltage** 



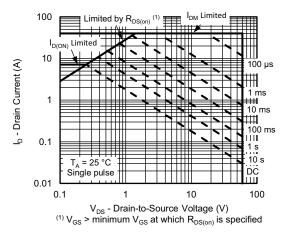
Power, Junction-to-Case



Threshold Voltage



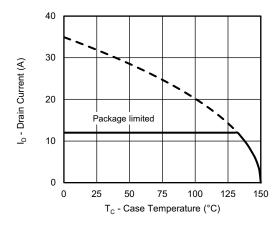
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient



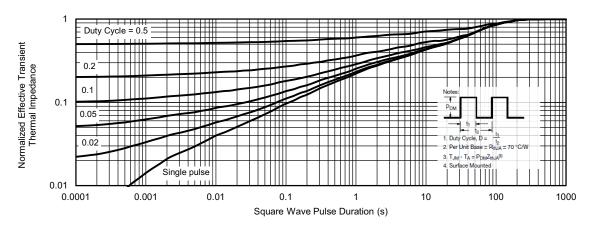
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



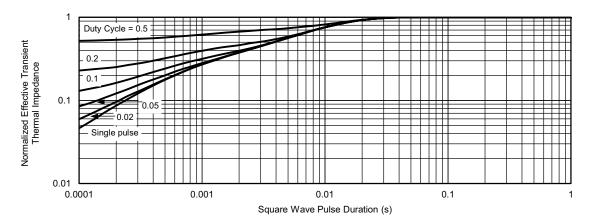
#### Note

a. The power dissipation  $P_D$  is based on  $T_J$  max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit

#### Current Derating a



#### Normalized Thermal Transient Impedance, Junction-to-Ambient

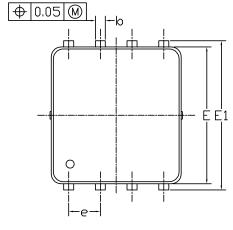


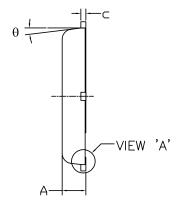
#### Normalized Thermal Transient Impedance, Junction-to-Foot

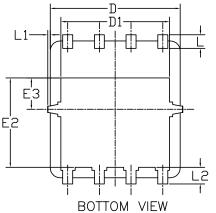
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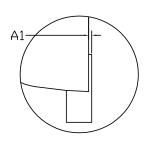


DFN5x6\_8L\_EP1\_P PACKAGE OUTLIN



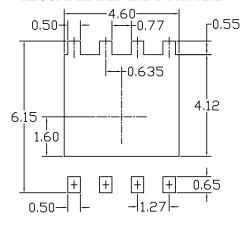






<u>VIEW 'A'</u> (SCALE 5:1)

#### RECOMMENDED LAND PATTERN



GVA (DOLG	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
3 I MIBOLS	MIN	NOM	MAX	MIN	NOM	MAX
A	0.85	0. 95	1.00	0.033	0.037	0.039
Al	0.00		0.05	0.000		0.002
b	0.30	0.40	0.50	0.012	0.016	0.020
c	0.15	0. 20	0. 25	0.006	0.008	0.010
D	5. 10	5. 20	5. 30	0. 201	0. 205	0. 209
D1	4. 25	4. 35	4. 45	0. 167	0. 171	0. 175
Е	5. 45	5. 55	5. 65	0.215	0.219	0. 222
E1	5. 95	6.05	6. 15	0. 234	0. 238	0. 242
E2	3. 525	3.625	3. 725	0.139	0.143	0. 147
E3	1. 175	1. 275	1.375	0.046	0.050	0.054
e	1. 27 BSC			0.050 BSC		
L	0.45	0. 55	0.65	0.018	0.022	0.026
L1	0		0. 15	0		0.006
L2	0.68 REF			0. 027 REF		
θ	0°		10°	0°		10°

#### **NOTE**

- UNIT: mm
- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVFRTFD INCH DIMFNSIONS ARF NOT NFCFSSARII Y FXACT



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